


<b>Search Notes</b> 	<b>Application/Control No.</b> 10500287	<b>Applicant(s)/Patent Under Reexamination</b> SASAKI ET AL.
	<b>Examiner</b> WEN-YING P CHEN	<b>Art Unit</b> 2871

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
class 349 combined with key words search of all databases in EAST	7/2/2008	wpc
citations search of relevant references	7/2/2008	wpc
general key words search of all databases in EAST	7/2/2008	wpc
reviewed previously cited references	9/25/2008	wpc

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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